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(12) **United States Design Patent**  
**Oonuma et al.**

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- (54) **ELECTRON MICROSCOPE**
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(\*\*) Term: **14 Years**

\* cited by examiner

(21) Appl. No.: **29/363,415**

*Primary Examiner* — Paula Greene

(22) Filed: **Jun. 9, 2010**

(74) *Attorney, Agent, or Firm* — Antonelli, Terry, Stout & Kraus, LLP.

(30) **Foreign Application Priority Data**

(57) **CLAIM**

Jan. 8, 2010 (JP) ..... 2010-000418

We claim the ornamental design for an electron microscope, as shown and described.

(51) **LOC (9) Cl.** ..... **16-06**

**DESCRIPTION**

(52) **U.S. Cl.** ..... **D16/131**

(58) **Field of Classification Search** ..... D16/131;  
250/311; 359/383, 384, 385, 389, 390, 368,  
359/370, 371, 372; D24/185, 232, 234; D10/81;  
D6/396; D23/286; 312/209  
See application file for complete search history.

FIG. 1 is a front, top and right side perspective view of an electron microscope showing our new design;  
FIG. 2 is a front elevational view thereof;  
FIG. 3 is a rear elevational view thereof;  
FIG. 4 is a top plan view thereof;  
FIG. 5 is a bottom plan view thereof;  
FIG. 6 is a left side elevational view thereof; and,  
FIG. 7 is a right side elevational view thereof.

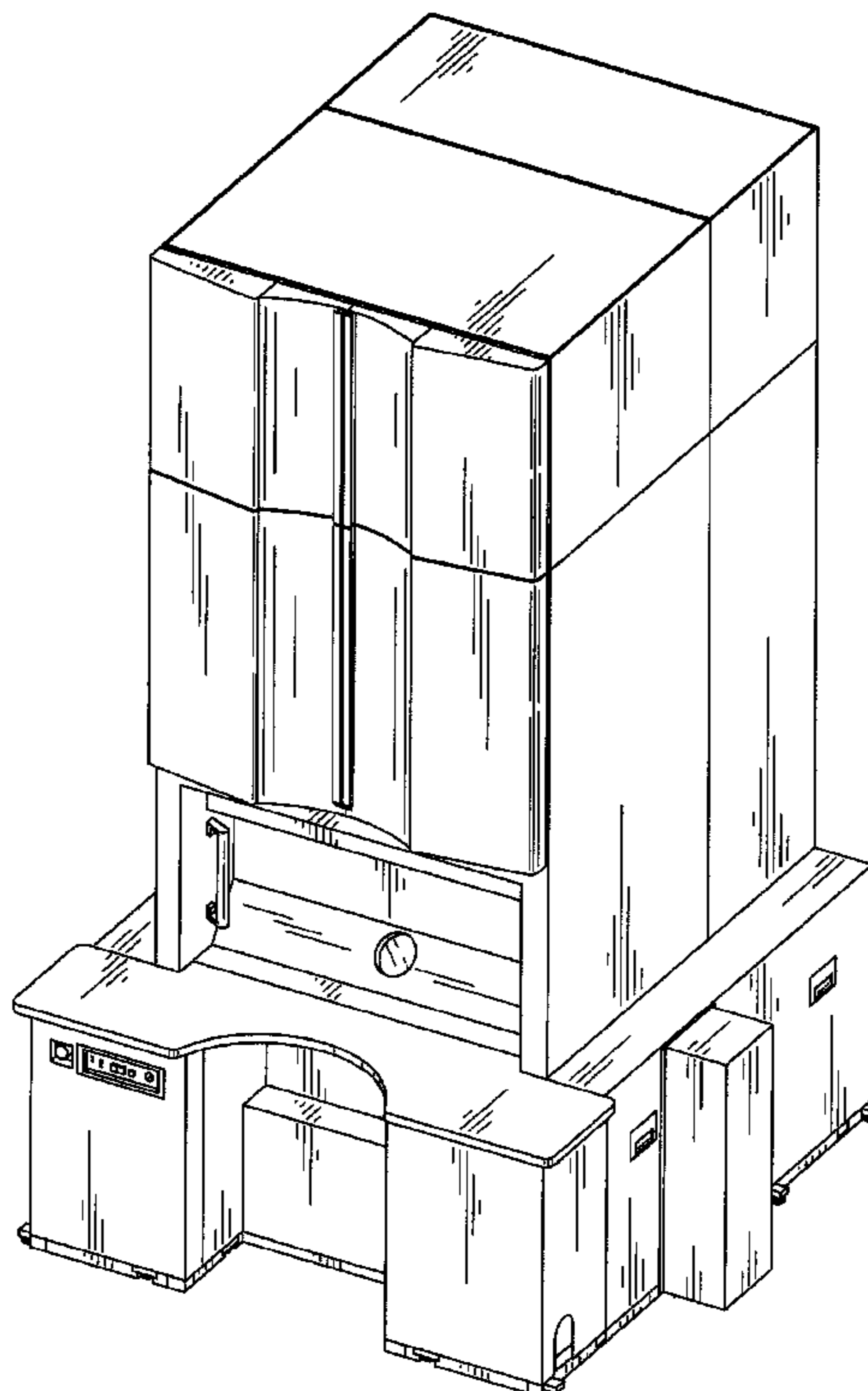
The broken lines shown are for illustrative purpose and form no part of the claimed design.

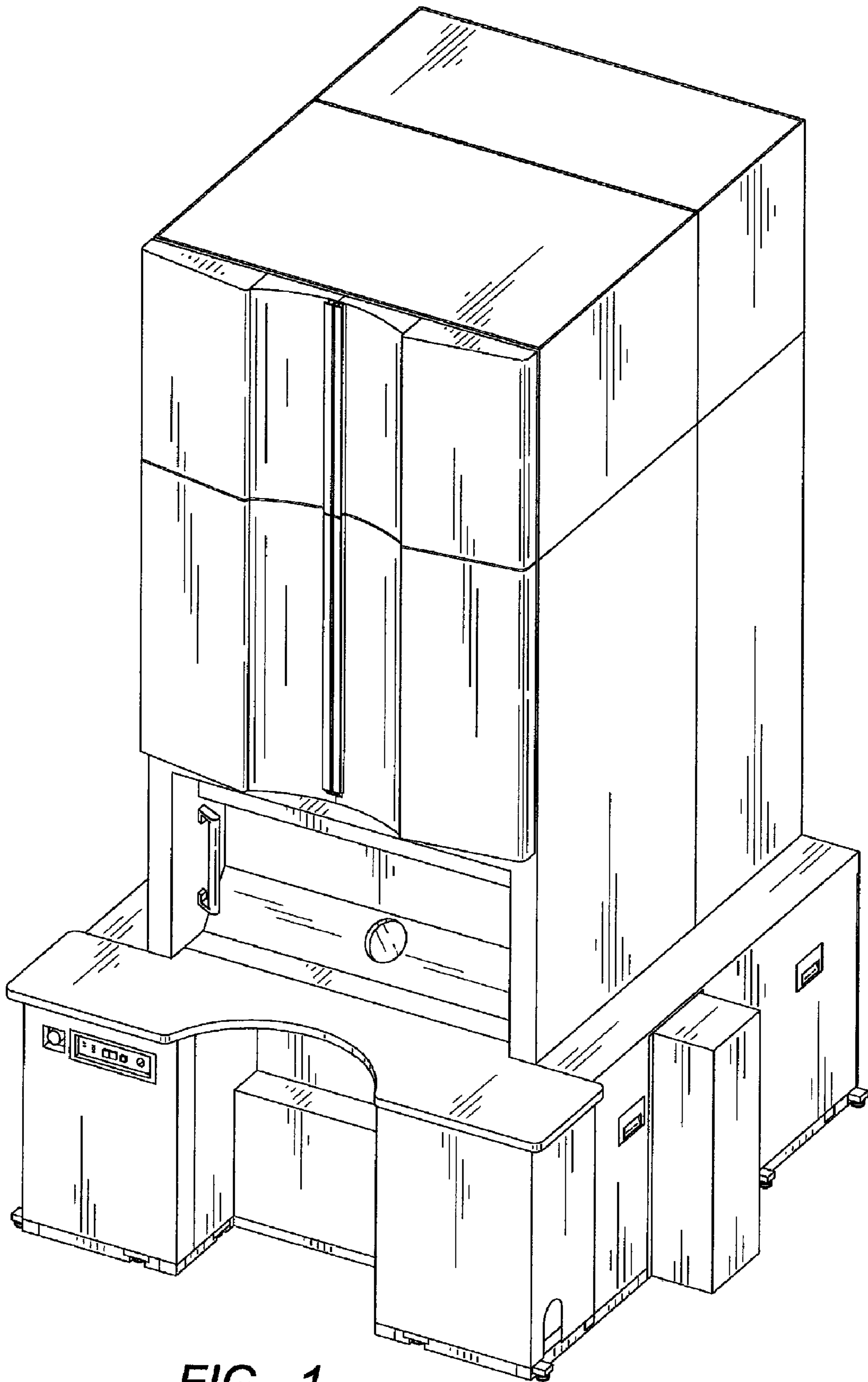
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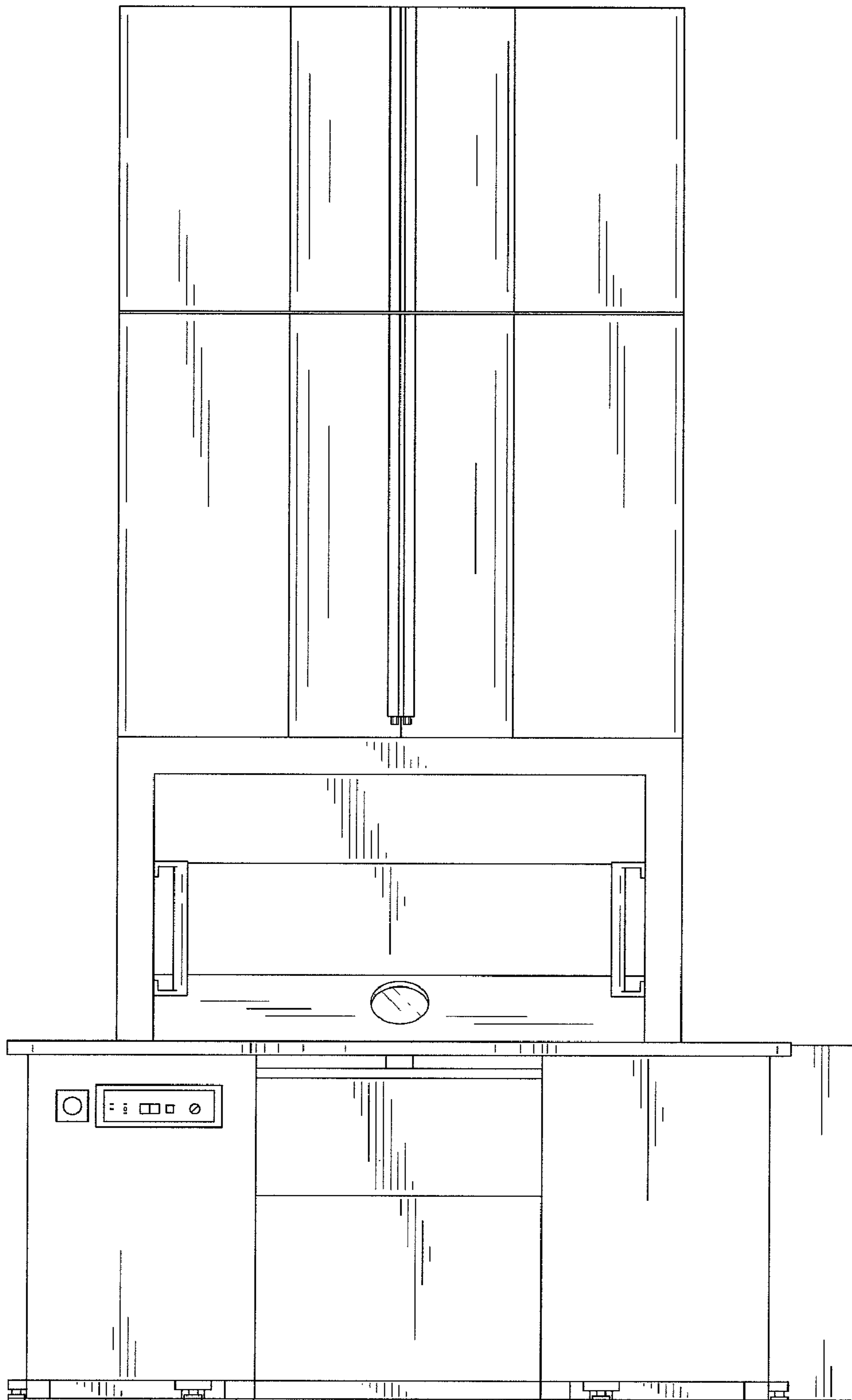
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**1 Claim, 7 Drawing Sheets**

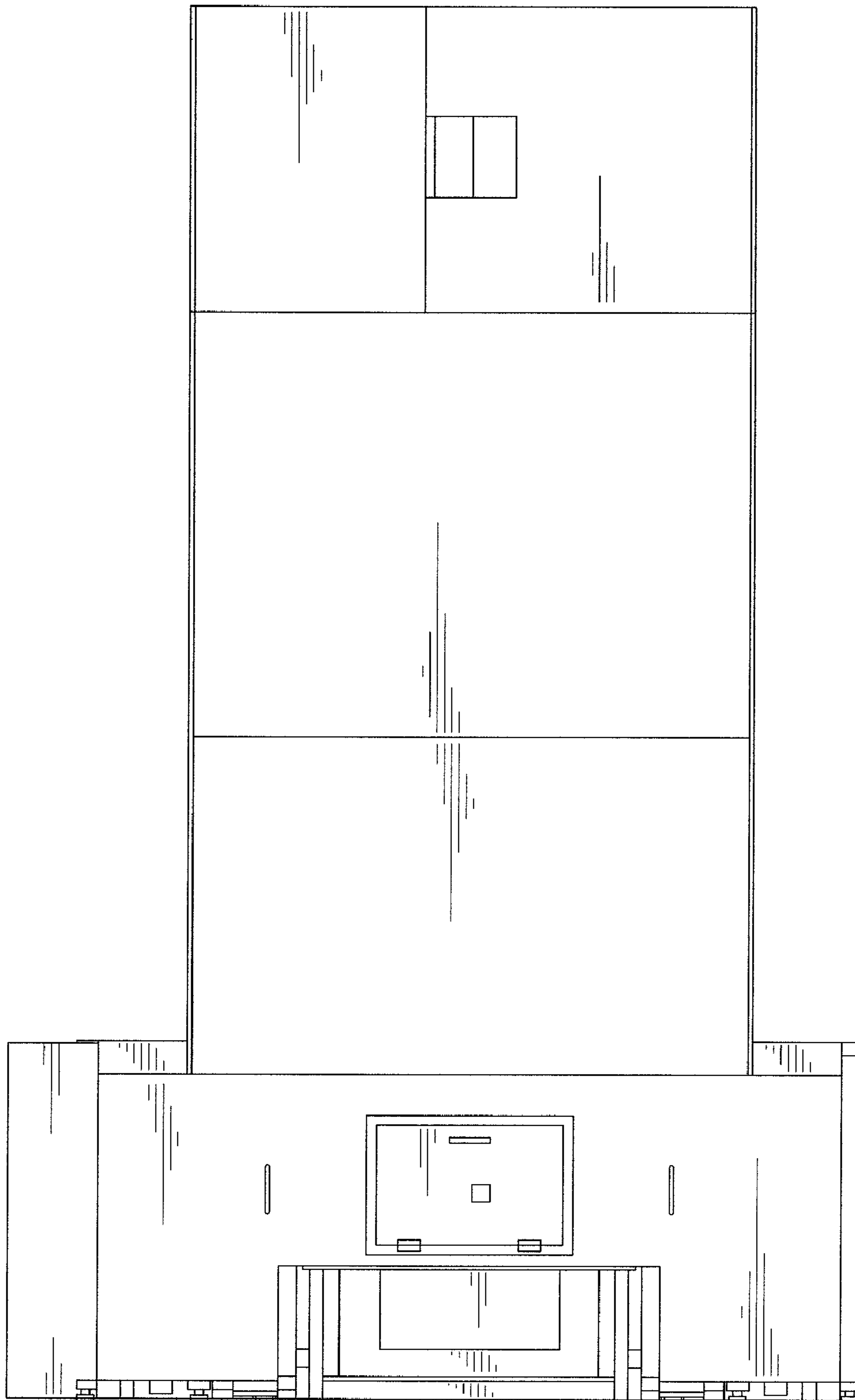




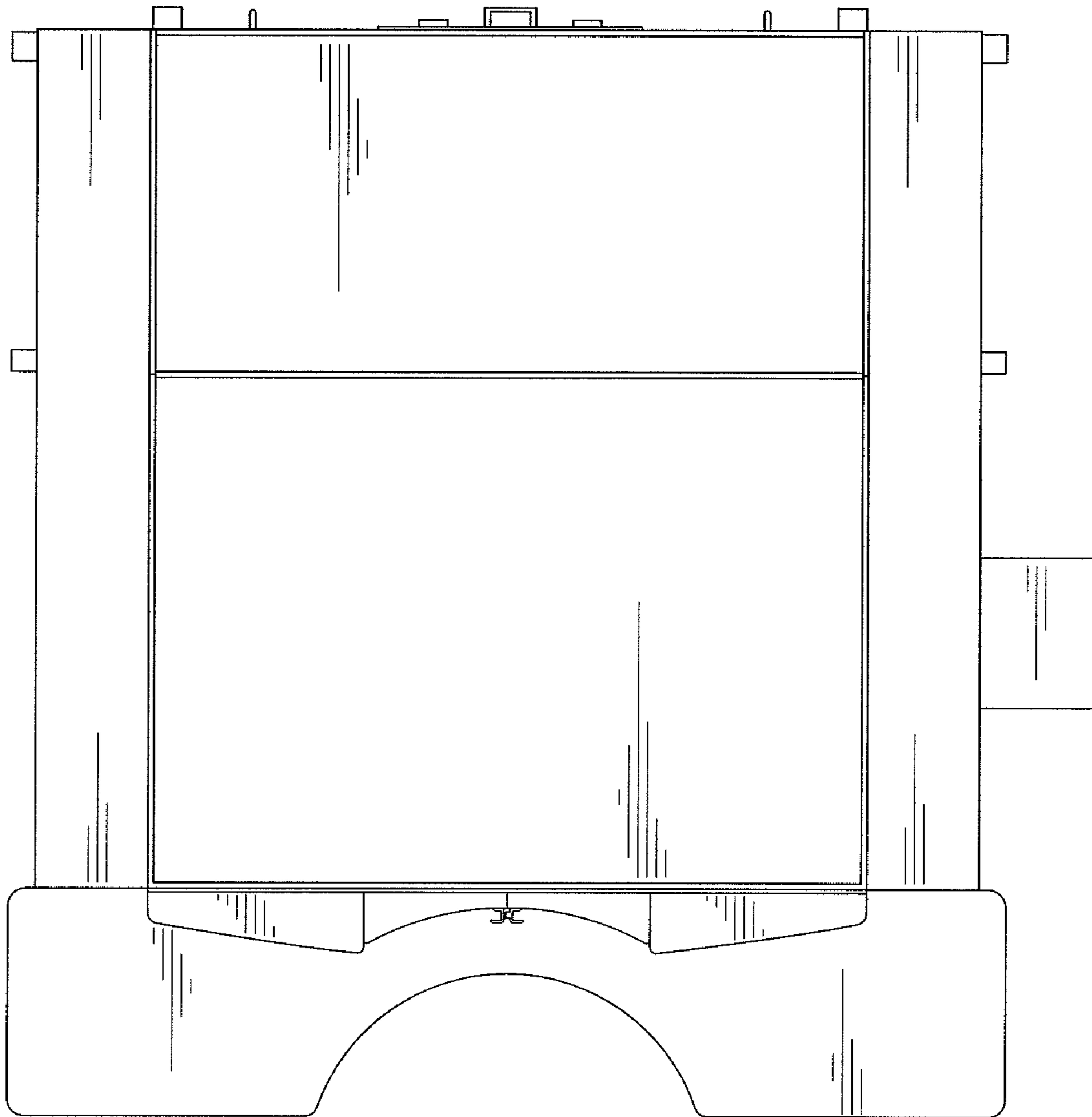
**FIG. 1**



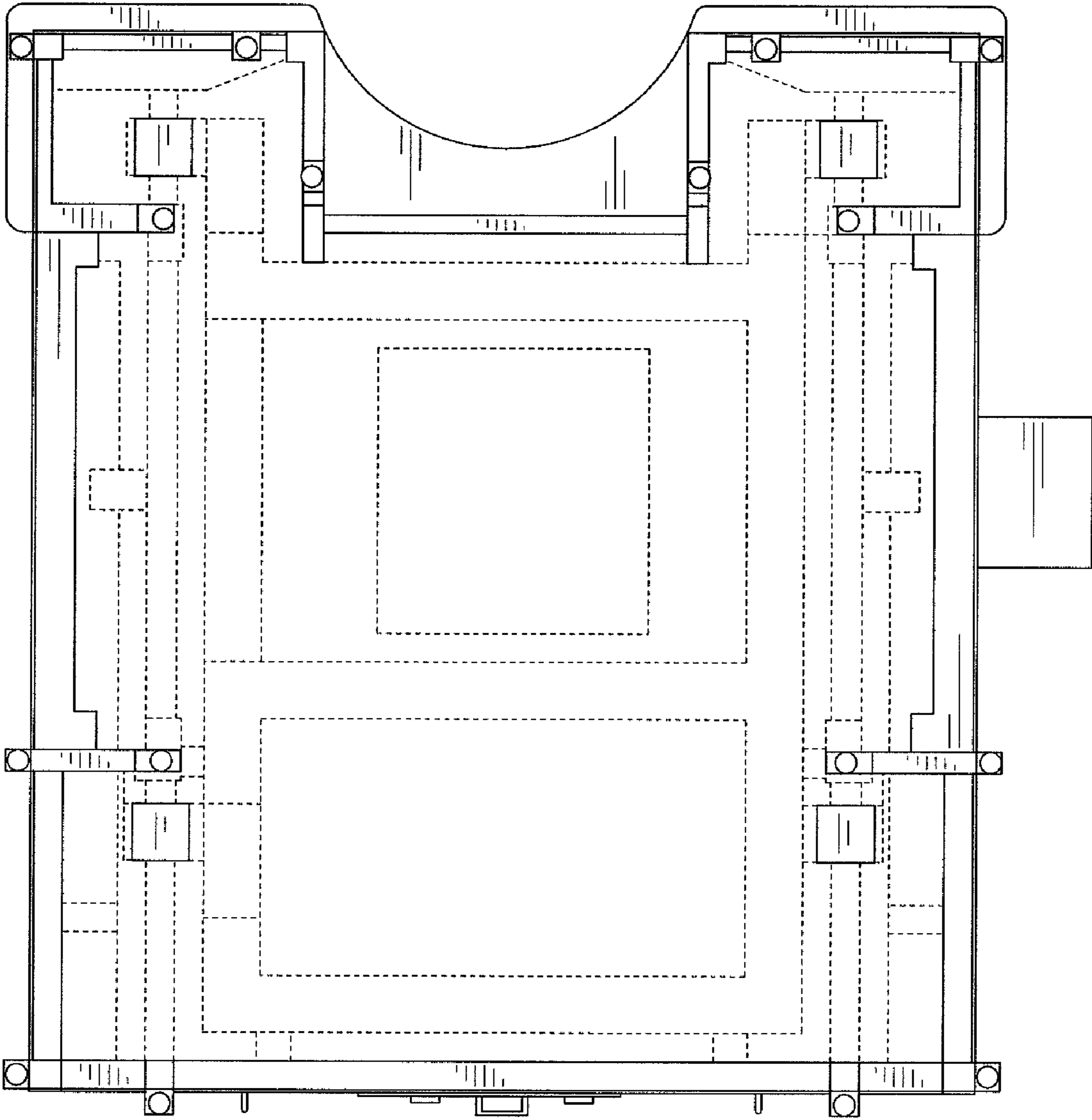
**FIG. 2**



**FIG. 3**



**FIG. 4**



**FIG. 5**

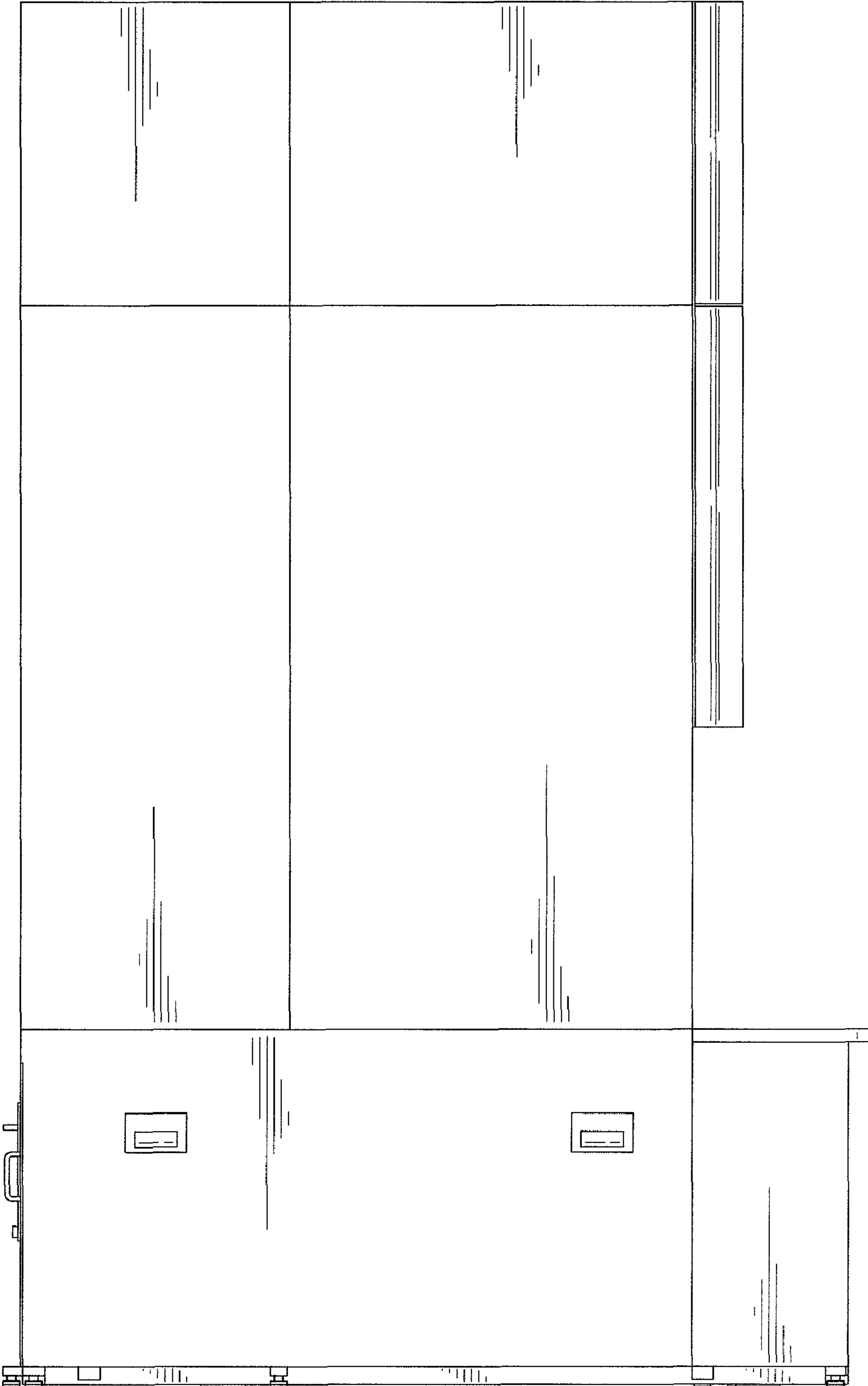
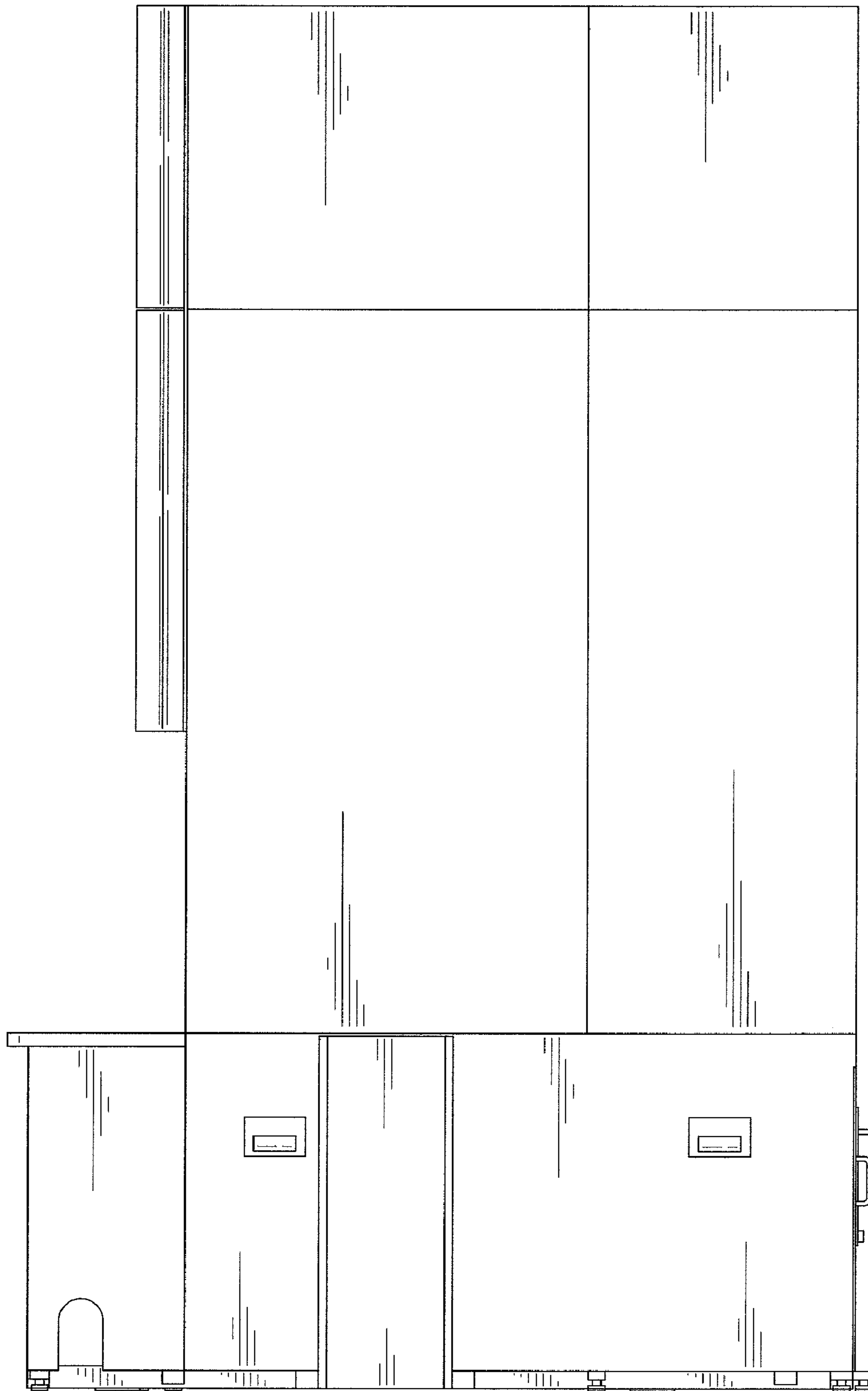


FIG. 6



**FIG. 7**